

Notice of References Cited

Application/Control No.

10/551,585

Applicant(s)/Patent Under
Reexamination
LEACH ET AL.

Examiner

HIEN NGUYEN

Art Unit

3768

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0046321	11-2001	MURAKAWA, AKIRA	382/190
*	B	US-2003/0035583	02-2003	Pelagotti et al.	382/217
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
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	T					

NON-PATENT DOCUMENTS

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